

100V/2A Peak, Low Cost, High Frequency Half Bridge Driver

The HIP2101 is a high frequency, 100V Half Bridge N-Channel power MOSFET driver IC. It is equivalent to the HIP2100 with the added advantage of full TTL/CMOS compatible logic input pins. The low-side and high-side gate drivers are independently controlled and matched to 13ns. This gives users total control over dead-time for specific power circuit topologies. Undervoltage protection on both the low-side and high-side supplies force the outputs low. An on-chip diode eliminates the discrete diode required with other driver ICs. A new level-shifter topology yields the low-power benefits of pulsed operation with the safety of DC operation. Unlike some competitors, the high-side output returns to its correct state after a momentary undervoltage of the high-side supply.

Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
HIP2101IB	-40 to 125	8 Ld SOIC	M8.15
HIP2101IBZ (Note 1)	-40 to 125	8 Ld SOIC (Pb-free)	M8.15
HIP2101EIB	-40 to 125	8 Ld EPSONIC	M8.15C
HIP2101EIBZ (Note 1)	-40 to 125	8 Ld EPSONIC (Pb-free)	M8.15C
HIP2101IR	-40 to 125	16 Ld 5x5 QFN	L16.5x5
HIP2101IRZ (Note 1)	-40 to 125	16 Ld 5x5 QFN (Pb-free)	L16.5x5
HIP2101IR4	-40 to 125	12 Ld 4x4 DFN	L12.4x4A
HIP2101IR4Z (Note 1)	-40 to 125	12 Ld 4x4 DFN (Pb-free)	L12.4x4A

NOTES:

- Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020C.
- Add "T" suffix for Tape and Reel packing option.

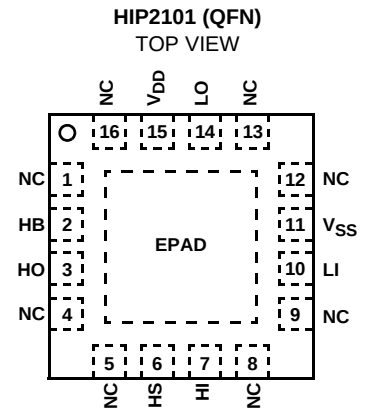
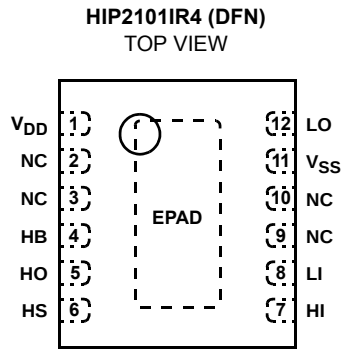
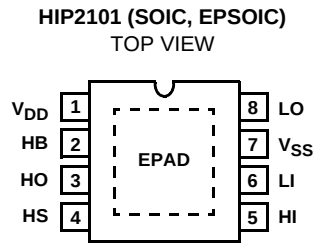
Features

- Drives N-Channel MOSFET Half Bridge
- SOIC, EPSONIC, QFN and DFN Package Options
- SOIC, EPSONIC and DFN Packages Compliant with 100V Conductor Spacing Guidelines of IPC-2221
- Pb-free Product Available (RoHS Compliant)
- Bootstrap Supply Max Voltage to 114VDC
- On-Chip 1Ω Bootstrap Diode
- Fast Propagation Times for Multi-MHz Circuits
- Drives 1000pF Load with Rise and Fall Times Typ. 10ns
- TTL/CMOS Input Thresholds Increase Flexibility
- Independent Inputs for Non-Half Bridge Topologies
- No Start-Up Problems
- Outputs Unaffected by Supply Glitches, HS Ringing Below Ground, or HS Slewing at High dv/dt
- Low Power Consumption
- Wide Supply Range
- Supply Undervoltage Protection
- 3Ω Output Driver Resistance
- QFN/DFN Package:
 - Compliant to JEDEC PUB95 MO-220 QFN - Quad Flat No Leads - Package Outline
 - Near Chip Scale Package footprint, which improves PCB efficiency and has a thinner profile

Applications

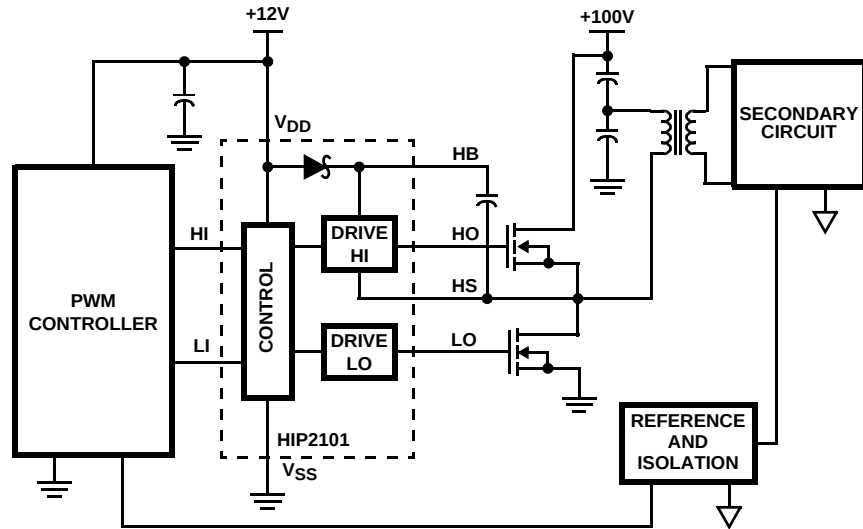
- Telecom Half Bridge Power Supplies
- Avionics DC-DC Converters
- Two-Switch Forward Converters
- Active Clamp Forward Converters

Pinouts

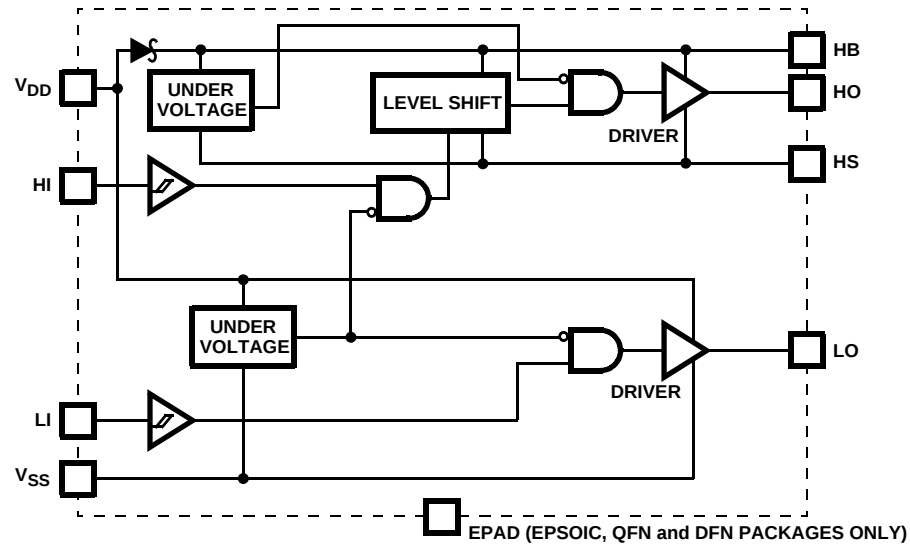


NOTE: EPAD = Exposed PAD.

Application Block Diagram



Functional Block Diagram



*EPAD = Exposed Pad. The EPAD is electrically isolated from all other pins. For best thermal performance connect the EPAD to the PCB power ground plane.

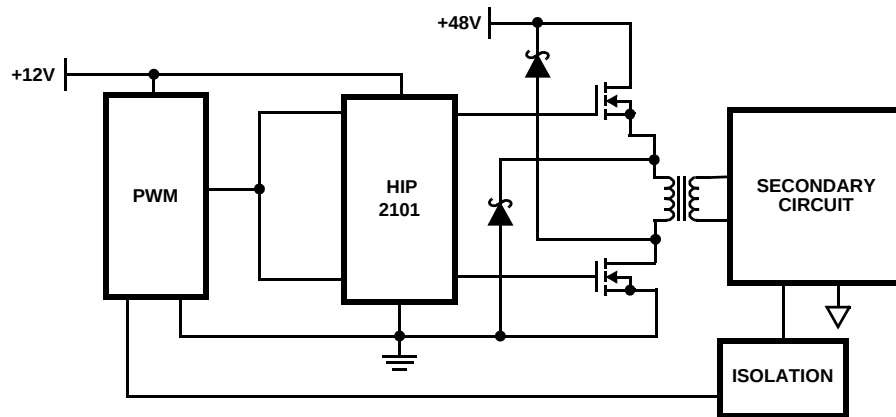


FIGURE 1. TWO-SWITCH FORWARD CONVERTER

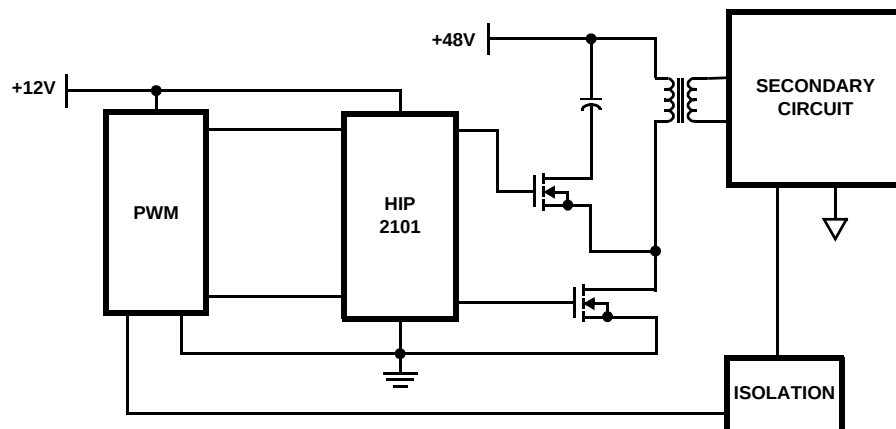


FIGURE 2. FORWARD CONVERTER WITH AN ACTIVE CLAMP

Absolute Maximum Ratings

Supply Voltage, V_{DD} , V_{HB} - V_{HS} (Notes 3, 4) -0.3V to 18V
 LI and HI Voltages (Note 4) -0.3V to 7.0V
 Voltage on LO (Note 4) -0.3V to V_{DD} +0.3V
 Voltage on HO (Note 4) V_{HS} -0.3V to V_{HB} +0.3V
 Voltage on HS (Continuous) (Note 4) -1V to 110V
 Voltage on HB (Note 4) +118V
 Average Current in V_{DD} to HB diode 100mA
 ESD Classification Class 1 (1kV)

Maximum Recommended Operating Conditions

Supply Voltage, V_{DD} +9V to 14.0VDC
 Voltage on HS -1V to 100V
 Voltage on HS (Repetitive Transient) -5V to 105V
 Voltage on HB . . . V_{HS} +8V to V_{HS} +14.0V and V_{DD} -1V to V_{DD} +100V
 HS Slew Rate <50V/ns

Thermal Information

Thermal Resistance (Typical)	θ_{JA} (°C/W)	θ_{JC} (°C/W)
SOIC (Note 5)	95	N/A
EPSON (Note 6)	40	3.0
QFN (Note 6)	37	6.5
DFN (Note 6)	40	3.0

Max Power Dissipation at 25°C in Free Air (SOIC, Note 5) 1.3W
 Max Power Dissipation at 25°C in Free Air (EPSON, Note 6) . . 3.1W
 Max Power Dissipation at 25°C in Free Air (QFN, Note 6) 3.3W
 Storage Temperature Range -65°C to 150°C
 Junction Temperature Range -55°C to 150°C
 Lead Temperature (Soldering 10s - SOIC Lead Tips Only) . . 300°C
 For Recommended soldering conditions see Tech Brief TB389.

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the recommended operating conditions of this specification is not implied.

NOTES:

- The HIP2101 is capable of derated operation at supply voltages exceeding 14V. Figure 16 shows the high-side voltage derating curve for this mode of operation.
- All voltages referenced to V_{SS} unless otherwise specified.
- θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- θ_{JA} is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. θ_{JC} , the "case temp" is measured at the center of the exposed metal pad on the package underside. See Tech Brief TB379.

Electrical Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, No Load on LO or HO, Unless Otherwise Specified

PARAMETERS	SYMBOL	TEST CONDITIONS	T _J = 25°C			T _J = -40°C TO 125°C		UNITS
			MIN	TYP	MAX	MIN	MAX	
SUPPLY CURRENTS								
V _{DD} Quiescent Current	I _{DD}	LI = HI = 0V	-	0.3	0.45	-	0.6	mA
V _{DD} Operating Current	I _{DDO}	f = 500kHz	-	1.7	3.0	-	3.4	mA
Total HB Quiescent Current	I _{HB}	LI = HI = 0V	-	0.1	0.15	-	0.2	mA
Total HB Operating Current	I _{HBO}	f = 500kHz	-	1.5	2.5	-	3	mA
HB to V _{SS} Current, Quiescent	I _{HBS}	V _{HS} = V _{HB} = 114V	-	0.05	1.5	-	10	μA
HB to V _{SS} Current, Operating	I _{HBSO}	f = 500kHz	-	0.7	-	-	-	mA
INPUT PINS								
Low Level Input Voltage Threshold	V _{IL}		0.8	1.65	-	0.8	-	V
High Level Input Voltage Threshold	V _{IH}		-	1.65	2.2	-	2.2	V
Input Pulldown Resistance	R _I		-	200	-	100	500	kΩ
UNDER VOLTAGE PROTECTION								
V _{DD} Rising Threshold	V _{DDR}		7	7.3	7.8	6.5	8	V
V _{DD} Threshold Hysteresis	V _{DDH}		-	0.5	-	-	-	V
HB Rising Threshold	V _{HBR}		6.5	6.9	7.5	6	8	V
HB Threshold Hysteresis	V _{HBH}		-	0.4	-	-	-	V

Electrical Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, No Load on LO or HO, Unless Otherwise Specified **(Continued)**

PARAMETERS	SYMBOL	TEST CONDITIONS	T _J = 25°C			T _J = -40°C TO 125°C		UNITS
			MIN	TYP	MAX	MIN	MAX	
BOOT STRAP DIODE								
Low-Current Forward Voltage	V _{DL}	I _{VDD-HB} = 100μA	-	0.45	0.70	-	0.7	V
High-Current Forward Voltage	V _{DH}	I _{VDD-HB} = 100mA	-	0.7	0.92	-	1	V
Dynamic Resistance	R _D	I _{VDD-HB} = 100mA	-	0.8	1	-	1.5	Ω
LO GATE DRIVER								
Low Level Output Voltage	V _{OLL}	I _{LO} = 100mA	-	0.25	0.3	-	0.4	V
High Level Output Voltage	V _{OHL}	I _{LO} = -100mA, V _{OHL} = V _{DD} -V _{LO}	-	0.25	0.3	-	0.4	V
Peak Pullup Current	I _{OHL}	V _{LO} = 0V	-	2	-	-	-	A
Peak Pulldown Current	I _{OLL}	V _{LO} = 12V	-	2	-	-	-	A
HO GATE DRIVER								
Low Level Output Voltage	V _{OLH}	I _{HO} = 100mA	-	0.25	0.3	-	0.4	V
High Level Output Voltage	V _{OHH}	I _{HO} = -100mA, V _{OHH} = V _{HB} -V _{HO}	-	0.25	0.3	-	0.4	V
Peak Pullup Current	I _{OHH}	V _{HO} = 0V	-	2	-	-	-	A
Peak Pulldown Current	I _{OLH}	V _{HO} = 12V	-	2	-	-	-	A

Switching Specifications $V_{DD} = V_{HB} = 12V$, $V_{SS} = V_{HS} = 0V$, No Load on LO or HO, Unless Otherwise Specified

PARAMETERS	SYMBOL	TEST CONDITIONS	$T_J = 25^\circ C$			$T_J = -40^\circ C$ TO $125^\circ C$		UNITS
			MIN	TYP	MAX	MIN	MAX	
Lower Turn-Off Propagation Delay (LI Falling to LO Falling)	t_{LPHL}		-	25	43	-	56	ns
Upper Turn-Off Propagation Delay (HI Falling to HO Falling)	t_{HPHL}		-	25	43	-	56	ns
Lower Turn-On Propagation Delay (LI Rising to LO Rising)	t_{LPLH}		-	25	43	-	56	ns
Upper Turn-On Propagation Delay (HI Rising to HO Rising)	t_{HPLH}		-	25	43	-	56	ns
Delay Matching: Lower Turn-On and Upper Turn-Off	t_{MON}		-	2	13	-	16	ns
Delay Matching: Lower Turn-Off and Upper Turn-On	t_{MOFF}		-	2	13	-	16	ns
Either Output Rise/Fall Time	t_{RC}, t_{FC}	$C_L = 1000pF$	-	10	-	-	-	ns
Either Output Rise/Fall Time (3V to 9V)	t_R, t_F	$C_L = 0.1\mu F$	-	0.5	0.6	-	0.8	us
Either Output Rise Time Driving DMOS	t_{RD}	$C_L = IRFR120$	-	20	-	-	-	ns
Either Output Fall Time Driving DMOS	t_{FD}	$C_L = IRFR120$	-	10	-	-	-	ns
Minimum Input Pulse Width that Changes the Output	t_{PW}		-	-	-	-	50	ns
Bootstrap Diode Turn-On or Turn-Off Time	t_{BS}		-	10	-	-	-	ns

Pin Descriptions

SYMBOL	DESCRIPTION
V _{DD}	Positive Supply to lower gate drivers. De-couple this pin to V _{SS} . Bootstrap diode connected to HB.
HB	High-Side Bootstrap supply. External bootstrap capacitor is required. Connect positive side of bootstrap capacitor to this pin. Bootstrap diode is on-chip.
HO	High-Side Output. Connect to gate of High-Side power MOSFET.
HS	High-Side Source connection. Connect to source of High-Side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
HI	High-Side input.
LI	Low-Side input.
V _{SS}	Chip negative supply, generally will be ground.
LO	Low-Side Output. Connect to gate of Low-Side power MOSFET.
EPAD	Exposed pad. Connect to ground or float. The EPAD is electrically isolated from all other pins.

Timing Diagrams

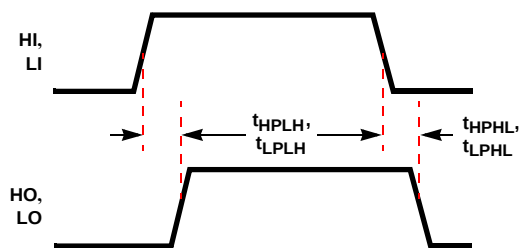


FIGURE 3.

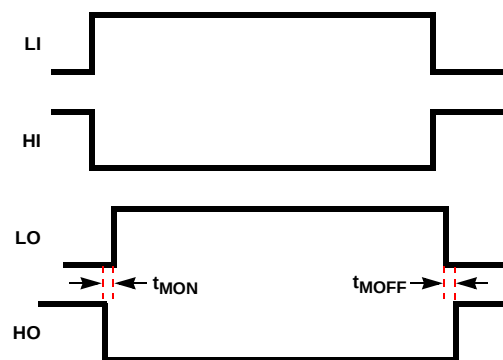


FIGURE 4.

Typical Performance Curves

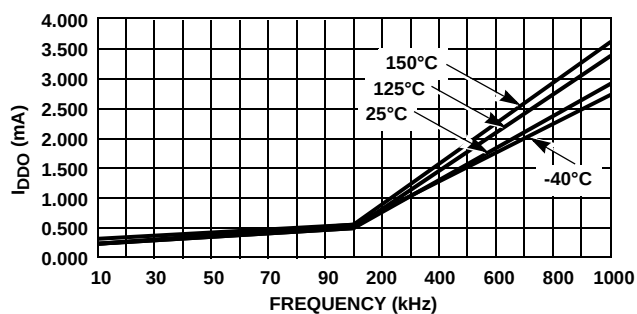


FIGURE 5A.

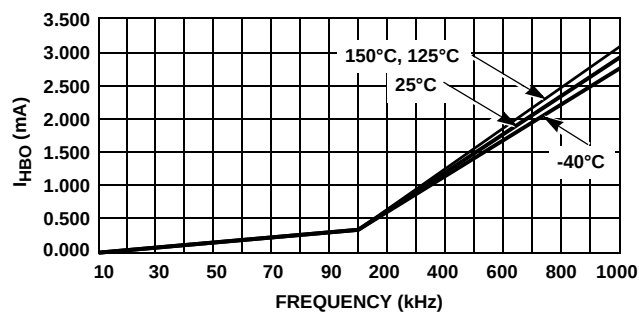


FIGURE 5B.

FIGURE 5. OPERATING CURRENT vs FREQUENCY

Typical Performance Curves (Continued)

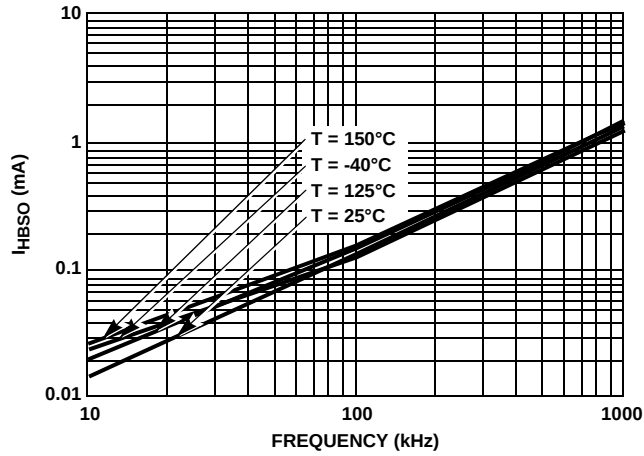


FIGURE 6. HB TO VSS OPERATING CURRENT vs FREQUENCY

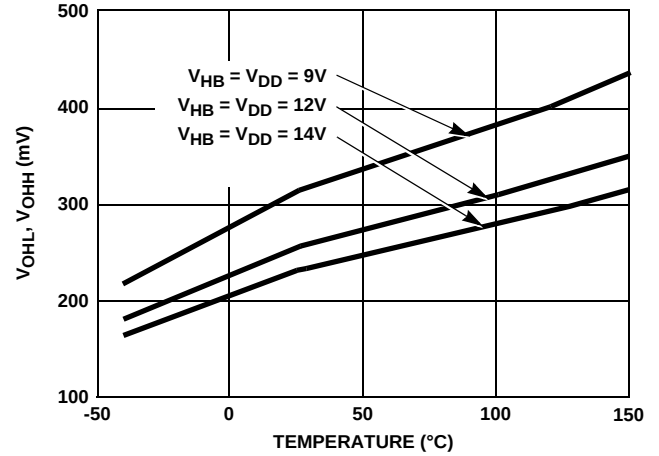


FIGURE 7. HIGH LEVEL OUTPUT VOLTAGE vs TEMPERATURE

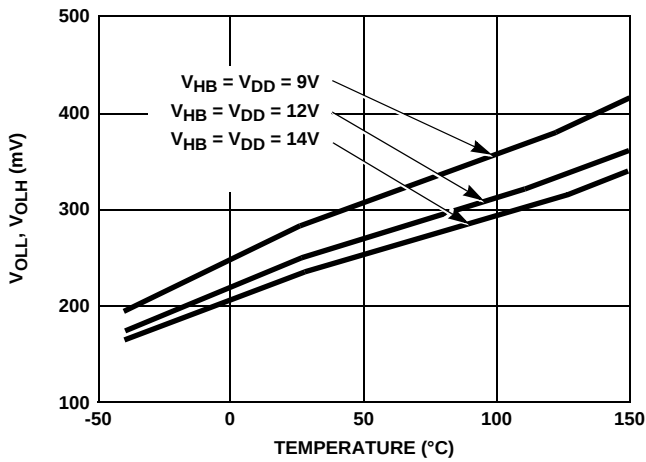


FIGURE 8. LOW LEVEL OUTPUT VOLTAGE vs TEMPERATURE

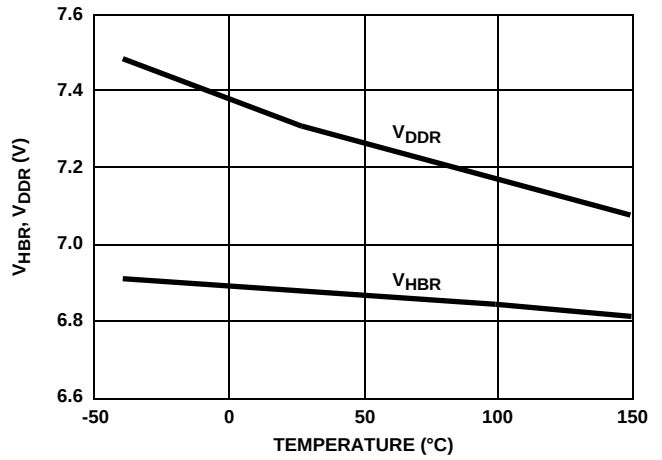


FIGURE 9. UNDERVOLTAGE LOCKOUT THRESHOLD vs TEMPERATURE

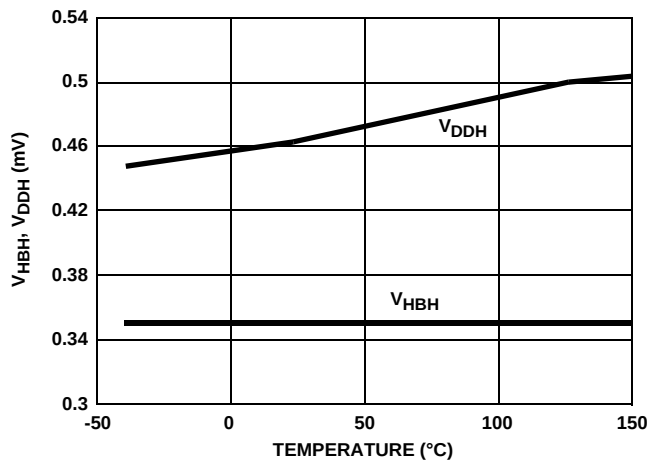


FIGURE 10. UNDERVOLTAGE LOCKOUT HYSTERESIS vs TEMPERATURE

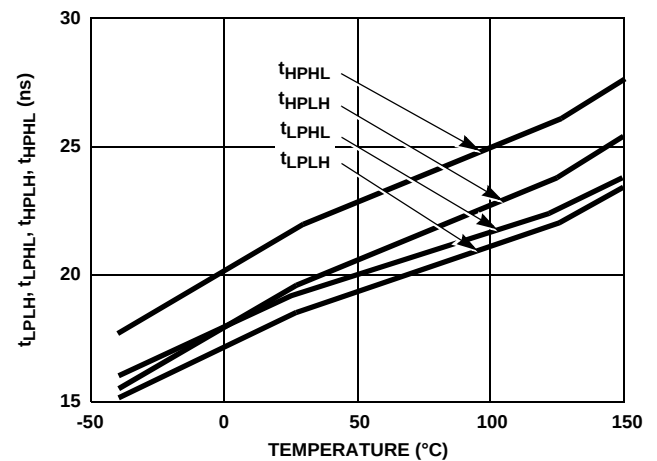


FIGURE 11. PROPAGATION DELAYS vs TEMPERATURE

Typical Performance Curves (Continued)

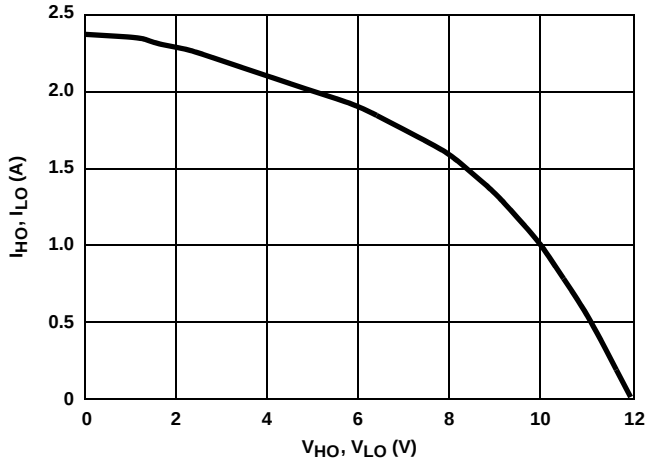


FIGURE 12. PEAK PULLUP CURRENT vs OUTPUT VOLTAGE

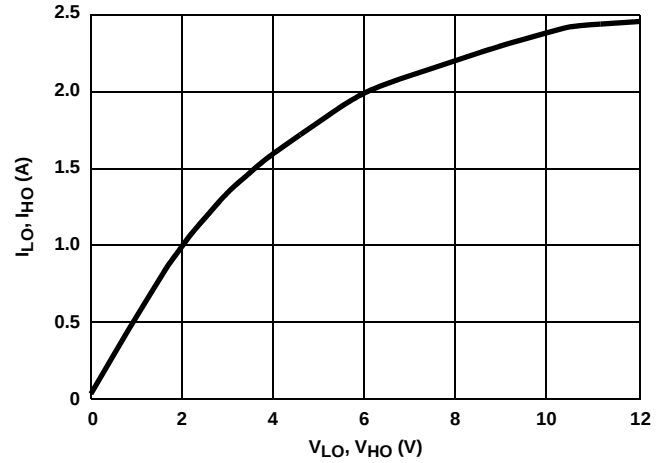


FIGURE 13. PEAK PULLDOWN CURRENT vs OUTPUT VOLTAGE

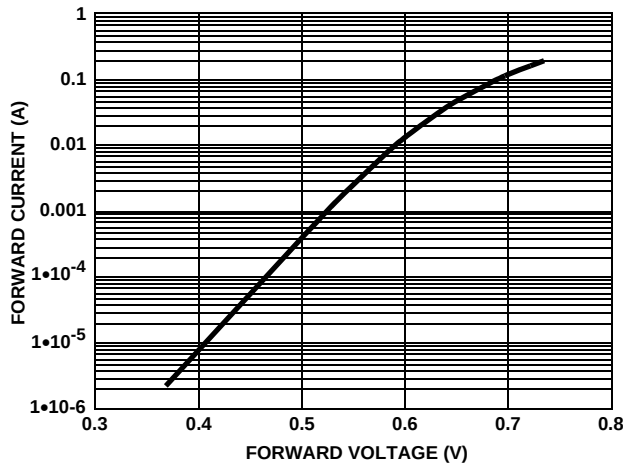


FIGURE 14. BOOTSTRAP DIODE I-V CHARACTERISTICS

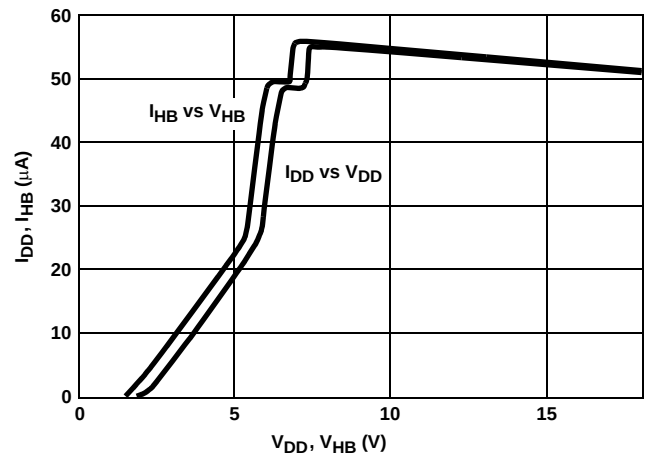


FIGURE 15. QUIESCENT CURRENT vs VOLTAGE

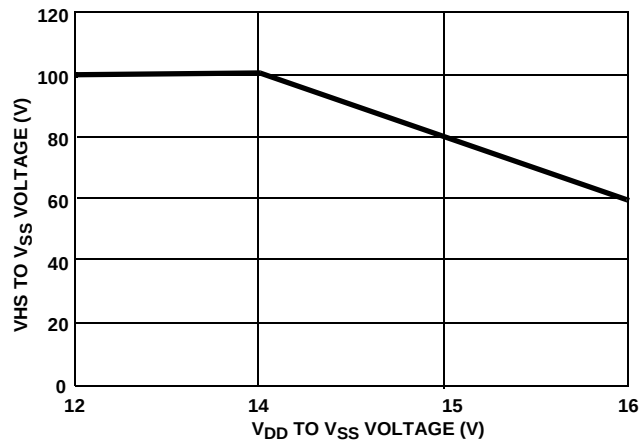
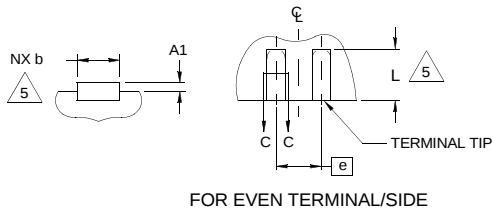
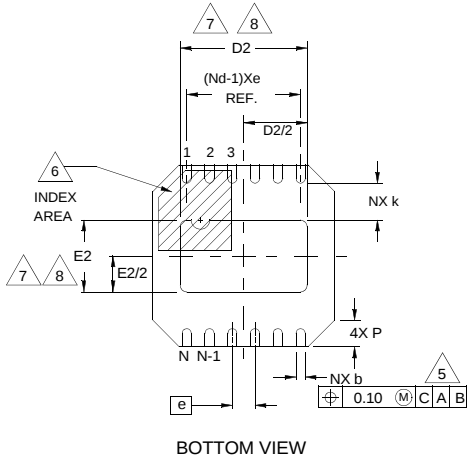
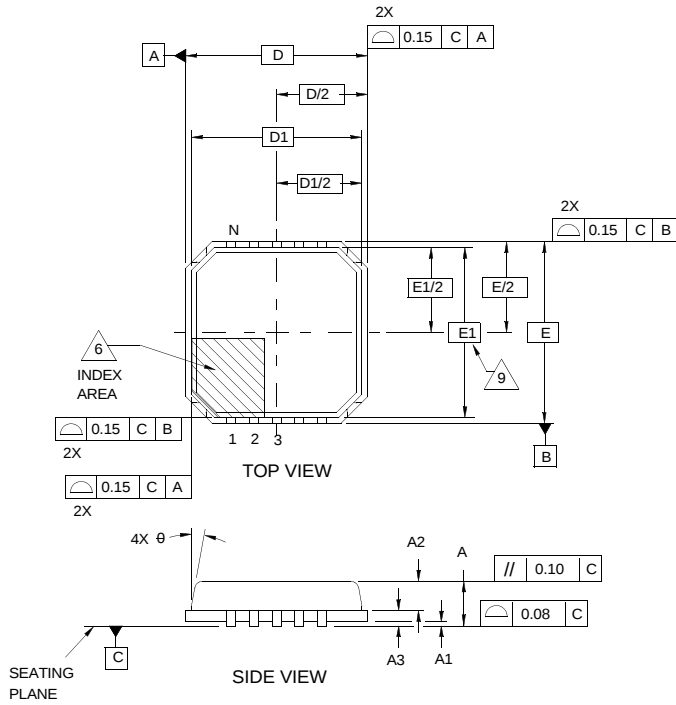


FIGURE 16. VHS VOLTAGE vs V_{DD} VOLTAGE

**Dual Flat No-Lead Plastic Package (DFN)
Micro Lead Frame Plastic Package (MLFP)**



L12.4x4A

12 LEAD DUAL FLAT NO-LEAD PLASTIC PACKAGE

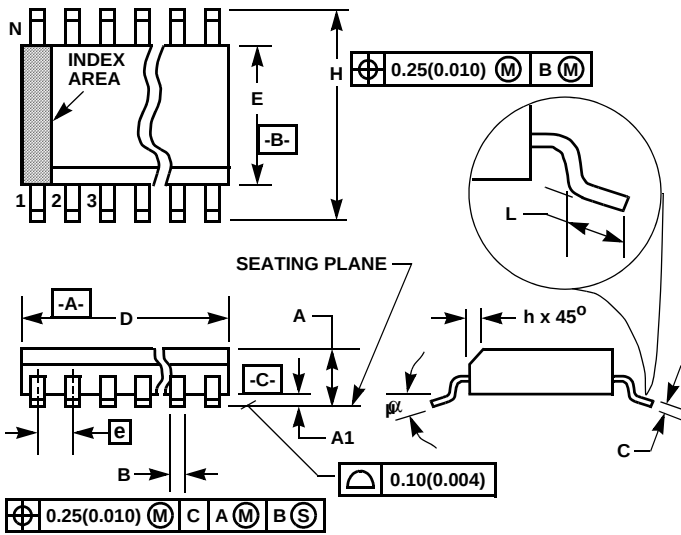
SYMBOL	MILLIMETERS			NOTES
	MIN	NOMINAL	MAX	
A	-	0.85	0.90	-
A1	0.00	0.01	0.05	-
A2	-	0.65	0.70	-
A3	0.20 REF			-
b	0.18	0.23	0.30	5, 8
D	4.00 BSC			-
D1	3.75 BSC			-
D2	2.65	2.80	2.95	7, 8
E	4.00 BSC			-
E1	3.75 BSC			-
E2	1.43	1.58	1.73	7, 8
e	0.50 BSC			-
k	0.635	-	-	-
L	0.30	0.40	0.50	8
N	12			2
Nd	6			3
P	0.24	0.42	0.60	-
θ	-	-	12	-

Rev. 0 8/03

NOTES:

1. Dimensioning and tolerancing conform to ASME Y14.5M-1994.
2. N is the number of terminals.
3. Nd refer to the number of terminals on D.
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
6. The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. COMPLIANT TO JEDEC MO-229-VGGD-2 ISSUE C except for the L dimension.

Small Outline Plastic Packages (SOIC)



NOTES:

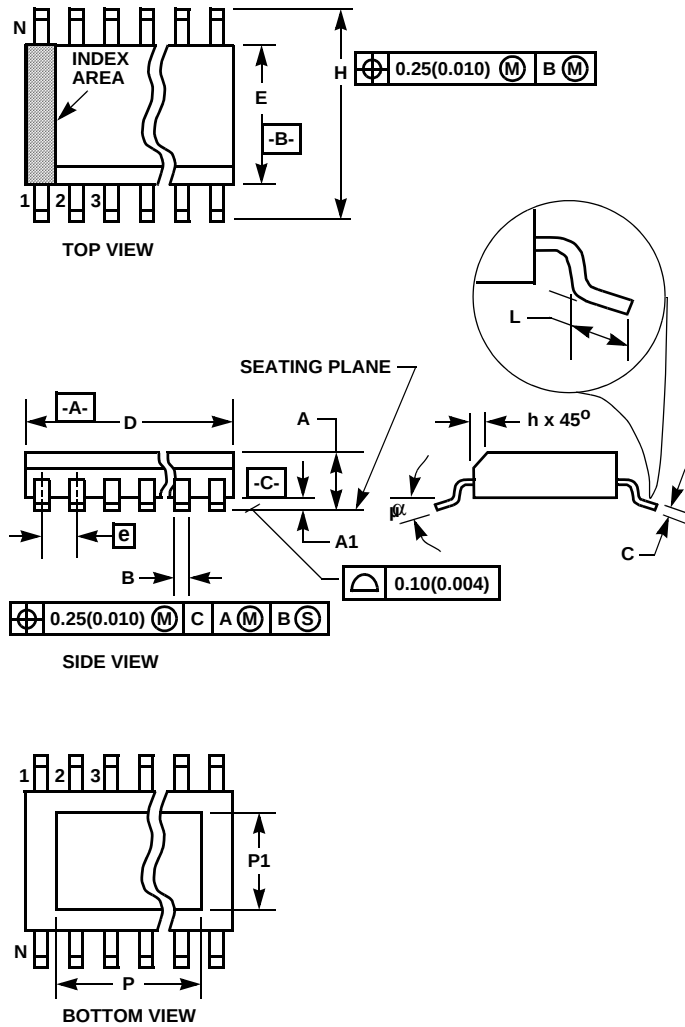
1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M8.15 (JEDEC MS-012-AA ISSUE C) 8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
B	0.013	0.020	0.33	0.51	9
C	0.0075	0.0098	0.19	0.25	-
D	0.1890	0.1968	4.80	5.00	3
E	0.1497	0.1574	3.80	4.00	4
e	0.050 BSC		1.27 BSC		-
H	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	8		8		7
α	0°	8°	0°	8°	-

Rev. 0 12/93

Small Outline Exposed Pad Plastic Packages (EPSOIC)



M8.15C

8 LEAD NARROW BODY SMALL OUTLINE EXPOSED PAD PLASTIC PACKAGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.056	0.066	1.43	1.68	-
A1	0.001	0.005	0.03	0.13	-
B	0.0138	0.0192	0.35	0.49	9
C	0.0075	0.0098	0.19	0.25	-
D	0.189	0.196	4.80	4.98	3
E	0.150	0.157	3.811	3.99	4
e	0.050 BSC		1.27 BSC		-
H	0.230	0.244	5.84	6.20	-
h	0.010	0.016	0.25	0.41	5
L	0.016	0.035	0.41	0.89	6
N	8		8		7
α	0°	8°	0°	8°	-
P	-	0.126	-	3.200	11
P1	-	0.099	-	2.514	11

Rev. 0 11/03

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
11. Dimensions "P" and "P1" are thermal and/or electrical enhanced variations. Values shown are maximum size of exposed pad within lead count and body size.

All Intersil U.S. products are manufactured, assembled and tested utilizing ISO9000 quality systems.

Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

Intersil products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design, software and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com